



Underwriters
Laboratories UL Japan, Inc.

Test report No. : 27KE0198-HO-B
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FCC ID : S4JS1613-01A

EMI TEST REPORT

Test Report No. : 27KE0198-HO-B

Applicant : NEC INFRONTIA CORPORATION

Type of Equipment : Mobile Terminal EX

Model No. : S1613-01A

FCC ID : S4JS1613-01A

**Test standard : FCC Part 15 Subpart E: 2007
Section 15.407**

Test Result : Complied

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.

Date of test: June 25 to August 22, 2007

Tested by:

Motoya Imura
EMC Services

Hisayoshi Sato
EMC Services

Takahiro Hatakeda
EMC Services

Shinya Watanabe
EMC Services

Hidekazu Tanaka
EMC Services

Kenichi Adachi
EMC Services

Approved by :

Hironobu Shimoji
Assistant Manager of
EMC Services

NVLAP LAB CODE: 200572-0

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UL Japan, Inc.

Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

MF060b (18.06.07)

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SECTION 1: Client information

Company Name : NEC INFRONTIA CORPORATION
 Address : 2-6-1 Kitamikata, Takatsu-Ku, Kawasaki 213-8511, Japan
 Telephone Number : +81- 44-820-3881
 Facsimile Number : +81- 44-820-4534
 Contact Person : Yoshihiro Hagiwara

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Mobile Terminal EX
 Model No. : S1613-01A
 Serial No. : #9 used for Radiated Spurious emission except below 1GHz, 11a Receiving
 #10 used for conducted emission, Radiated spurious emission test below
 1GHz, 11a Receiving and Antenna terminal conducted test.
 Rating : DC12V (AC Adapter input: AC100V-240V)
 Country of Manufacture : Japan
 Receipt Date of Sample : June 22, 2007
 Condition of EUT : Production prototype
 (Not for Sale: This sample is equivalent to mass-produced items.)
 Modification of EUT : No modification by the test lab.

2.2 Product Description

Model No: S1613-01A (referred to as the EUT in this report) is the Mobile Terminal EX.

Clock frequency : 1GHz (CPU), 40MHz (Wireless LAN port)

Equipment Type	Transceiver				
Frequency of Operation	11b/11g	2412MHz - 2462MHz *1)			
	11a	Low	5180MHz - 5240MHz		
		Mid	5260MHz - 5320MHz *2)		
		Add	5500MHz - 5700MHz *2)		
		Upper	5745MHz - 5805MHz 5825MHz *1)		
Type of Modulation	11b	DSSS DBPSK DQPSK CCK	: 1Mbps : 2Mbps : 5.5Mbps, 11Mbps		
	11a/11g	OFDM BPSK QPSK 16QAM 64QAM	: 6Mbps, 9Mbps : 12Mbps, 18Mbps : 24Mbps, 36Mbps : 48Mbps, 54Mbps		
Channel spacing	11b/11g	5MHz			
	11a	20MHz			
Power Supply (inner)	DC3.3V, DC1.8V				
Antenna Type	Internal antenna				
Antenna Connector Type	U.FL (ANT-A and ANT-B)				
Antenna Gain	0dBi				

*1) Refer to 27KE0198-HO-A, FCC Part 15 Subpart C report.

*2) Refer to 27KE0198-HO-C, FCC Part 15 Subpart E (FCC 15.407 DFS test only) report.

Remarks : This Wireless Module consists of 1 chip each of 2.4GHz band and 5GHz band.

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part15 Subpart E : 2007
Title : FCC 47CFR Part15 Radio Frequency Device
Subpart E Unlicensed National Information Infrastructure Devices
Section 15.407 General technical requirements

FCC 15.31 (e)

This EUT provides stable voltage(DC3.3, 1.8V) constantly to RF Module regardless of input voltage. Therefore, this EUT complies with the requirement.

3.2 Procedures and results

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	26dB Emission Bandwidth	FCC :ANSI C63.4:2003 IC: -	FCC : 15.407(a)(1)(2)(3) IC:-	Conducted	N/A	See data	Complied
2	Maximum Peak Output Power	FCC :ANSI C63.4:2003 IC: RSS-Gen 4.8	FCC : 15.407(a)(1)(2)(3) IC: RSS-210 A.9.2 (1)(2)(3)				Complied
3	Peak Power Spectral Density	FCC :ANSI C63.4:2003 IC: RSS-210 A9.2 (1)(2)(3)	FCC : 15.407(a)(1)(2)(3)(5) IC: RSS-210 A.9.2 (1)(2)(3)	Conducted	N/A		Complied
4	Peak Excursion Ratio	FCC :ANSI C63.4:2003 IC: -	FCC : 15.407(a)(6) IC: -				Complied
5	Spurious Emission	FCC: ANSI C63.4:2003 IC: RSS-Gen 4.9, 4.10	FCC : 15.407(b)(1)(2)(3)(4)(5)(6)(7), 15.205and15.209 IC: RSS-210 A.9.3 (1)(2)(3)(4)	Conducted Radiated	N/A	[Tx] 1.5dB 166.508MHz Horizontal Tx 5500MHz [Rx] 0.6dB 47.801MHz Vertical Rx5260MHz	Complied
6	Conducted Emission	FCC :ANSI C63.4:2003 IC: RSS-Gen 7.2.2	FCC: 15.407(b)(6)/15.207 IC: RSS-Gen 7.2.2				Complied
7	Band Edge Compliance 26dB Emission Bandwidth	FCC :ANSI C63.4:2003 IC: -	FCC : 15.407(b)(1)(2)(3)(4)(7)/15.205 and 15.209 IC: RSS-210 A.9.3 (1)(2)(3)(4)	Conducted Radiated	N/A	See data	Complied

Note: UL Japan, Inc.'s EMI Work Procedures No.QPM05 and QPM15.

*These tests were also referred to FCC Public Notice DA 02-2138 "Measurement Procedure Updated for Peak Transmit Power in the Unlicensed National Information Infrastructure (U-NII) Bands".

*These tests were performed without any deviations from test procedure except for additions or exclusions.

3.3 Addition to standards

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	99% Occupied Band Width	RSS-Gen 4.6.1	-	Conducted	N/A	N/A	N/A

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4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

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3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Conducted Emission

The measurement uncertainty for this test is ± 2.66 dB.

The data listed in this test report has enough margin, more than the site margin.

Spurious Emission (Radiated)

The measurement uncertainty for this test using Biconical antenna is ± 4.59 dB(3m)/ ± 4.58 dB(10m).

The measurement uncertainty for this test using Logperiodic antenna is ± 4.62 dB(3m)/ ± 4.60 dB(10m).

The measurement uncertainty for this test using Horn antenna is ± 5.27 dB.

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

Other test except Conducted Emission and Spurious Emission (Radiated)

The measurement uncertainty for this test is ± 3.0 dB.

3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	IC4247	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	IC4247-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	IC4247-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	IC4247-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Test instruments and Data of EMI

Refer to APPENDIX 1 to 3.

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Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

The EUT was operating in a manner similar to typical use during the tests.

The mode used for test :

WLAN Transmitting (Tx) 11a mode (Payload: PN9)

- Low-Band / Low Channel : 5180MHz
- Mid-Band / Low Channel : 5260MHz
- High Channel : 5320MHz
- Additional-Band / Low Channel : 5500MHz
- Mid Channel : 5600MHz
- High Channel : 5700MHz
- High-Band / Low Channel : 5745MHz
- Mid Channel : 5765MHz
- High Channel : 5805MHz

WLAN Receiving (Rx) 11a mode

- Mid-Band / Low Channel : 5260MHz
- Additional-Band / Mid Channel : 5600MHz
- High- Band / Mid- Channel : 5765MHz

Conditions : 1) Data Rate : 11a:6Mbps, 9Mbps, 12Mbps, 18Mbps, 24Mbps, 36Mbps, 48Mbps, 54Mbps
2) Antenna Connector: ANT-A, ANT-B

As a result of preliminary test, the formal test was performed under the worst conditions of the above modes.
See the below table for the details of the worst conditions.

Worst Conditions:

Test Item	IEEE802.11a
All tests	Data Rate: 54Mbps Antenna Connector: ANT A

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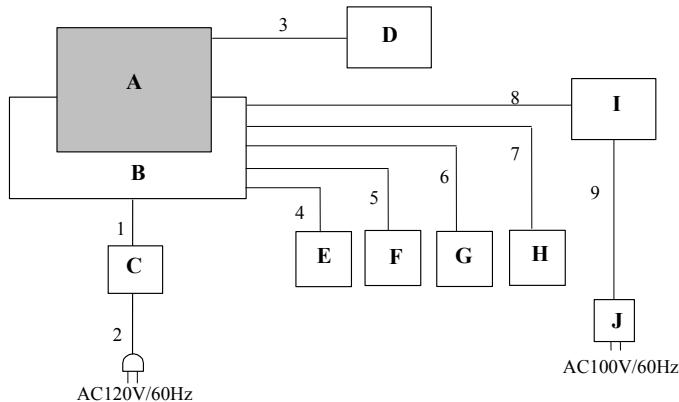
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Facsimile : +81 596 24 8124

4.2 Configuration and peripherals

1) Conducted emission test and Radiated spurious emission test



* Cabling and setup were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Mobile Terminal EX	S1613-01A	#9 *1), #10 *2)	NEC INFRONTIA	EUT
B	Single Docking Station EX	3024A APX	000109022593	NEC INFRONTIA	-
C	AC Adaptor	SQN36W12P-00	0403A0000176G	NAGANO	-
D	Headphone	LT-100	-	Panasonic	-
E	USB Keyboard	TK-U12FY	040107169	ELECOM	-
F	Mouse	M-UB48	LZE02650788	Logitech	-
G	Ten key	TK-BT3	0609200440	ELECOM	-
H	External Floppy Disk Drive	CF-VFDU03	0322374	Panasonic	-
I	Wireless LAN access point	CG-WLBARAG2	1072210051202516	Corega	-
J	AC Adaptor	MT18-3053280-A1	-	Corega	-

*1) Used for Radiated spurious emission test except below 1GHz, 11a Receiving.

*2) Used for Conducted emission and Radiated spurious emission below 1GHz, 11a Receiving.

List of cables used

No.	Name	Length (m)	Shield	
			Cable	Connector
1	DC Cable	1.2	Unshielded	Unshielded
2	AC Cable	1.8	Unshielded	Unshielded
3	Audio Cable	3.0	Unshielded	Unshielded
4	USB Cable	1.4	Shielded	Shielded
5	USB Cable	0.8	Shielded	Shielded
6	USB Cable	0.8	Shielded	Shielded
7	USB Cable	0.3	Shielded	Shielded
8	LAN Cable	2.0	Unshielded	Unshielded
9	DC Cable	1.8	Unshielded	Unshielded

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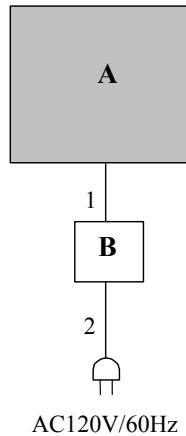
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2) Antenna terminal conducted test



* Cabling and setup were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Mobile Terminal EX	S1613-01A	#10	NEC INFRONTIA	EUT
B	AC Adaptor	S1596-04/ADPI004	0604B0002947G	NEC INFRONTIA	-

List of cables used

No.	Name	Length (m)	Shield	
			Cable	Connector
1	DC Cable	1.2	Unshielded	Unshielded
2	AC Cable	1.8	Unshielded	Unshielded

SECTION 5: Conducted Emission

Test Procedure

EUT was placed on a urethane platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center .

For the tests on EUT with other peripherals (as a whole system)

I/O cable and AC cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber or a Measurement Room.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

Detector	: quasi-peak and average detector (IF BW 9 kHz)
Measurement range	: 0.15-30MHz
Test data	: APPENDIX 2
Test result	: Pass

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SECTION 6: Spurious Emission and Band Edge Compliance

[Conducted]

Test Procedure

The Out of Band Emission was measured with a spectrum analyzer connected to the antenna port.

Test data : APPENDIX 2
Test result : Pass

[Radiated]

Test Procedure

EUT was placed on a urethane platform of nominal size, 1.5m by 1m, raised 80cm above the conducting ground plane. The Radiated Electric Field Strength intensity has been measured in a Semi Anechoic Chamber with a ground plane and at a distance of 3m(Below 10GHz) , 1m(10-26.5GHz, Distance Factor : $20\log(3[m]/1[m])$) and 0.5m(Upper 26.5GHz, Distance Factor : $20\log(3[m]/0.5[m])$).

The height of the measuring varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver or the Spectrum Analyzer.

Below 1GHz

The result also satisfied with the general limits specified in section 15.209(a).

Above 1GHz

Inside of the restricted bands (Section 15.205) : Apply to limit in the Section 15.209(a)

Outside of the restricted bands (Section 15.407) : Limit -27dBm EIRP

-17dBm EIRP (5.725-5.825GHz Band Edge)

Frequency	Below 1GHz	Above 1GHz (Inside of the restricted bands)	Above 1GHz (Outside of the restricted bands)
Instrument use	Test Receiver	Spectrum Analyzer	Spectrum Analyzer
Detector IF Bandwidth	QP: BW 120kHz	PK: RBW:1MHz/VBW: 1MHz AV: RBW:1MHz/VBW:10Hz	RBW:1MHz/VBW: 1MHz

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Test data : APPENDIX 2
Test result : Pass

*The noise from the EUT was not seen in the above 18GHz. The measurement was made in the residual noise levels.

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4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

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SECTION 7: Emission Bandwidth

Test Procedure

Emission Bandwidth was measured with a spectrum analyzer connected to the antenna port.

Test data : APPENDIX 2
Test result : Pass

SECTION 8: Maximum Peak Output Power

Test Procedure

The Peak Transmit Power was measured with a spectrum analyzer connected to the antenna port. The test was made with the spectrum analyzer that has a function of channel-power measurement. We followed the method 1 specified in DA 02-2138.

Test data : APPENDIX 2
Test result : Pass

SECTION 9: Peak Power Spectral Density

Test Procedure

The Peak Power Spectral Density was measured with a spectrum analyzer connected to the antenna port. We followed the method 2 specified in DA 02-2138.

Test data : APPENDIX 2
Test result : Pass

SECTION 10: Peak Excursion Ratio

Test Procedure

The Peak Excursion Ratio was measured with a spectrum analyzer connected to the antenna port. The second Sweep was measured based on Method 1(Maximum Peak Output Power) specified in DA 02-2138.

Test data : APPENDIX 2
Test result : Pass

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4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

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Facsimile : +81 596 24 8124